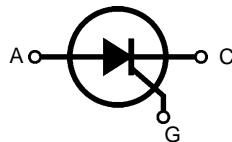


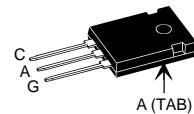
Phase Control Thyristor

V_{RRM} = 800-1600 V
I_{T(RMS)} = 75 A
I_{T(AV)M} = 48 A

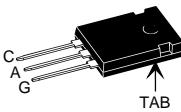
V _{RSM}	V _{RRM}	Type
V _{DSM}	V _{DRM}	
V	V	
900	800	CS 45-08io1
1300	1200	CS 45-12io1
1700	1600	CS 45-16io1 CS 45-16io1R



TO-247 AD
Version io1



ISOPLUS 247™
Version io1R



C = Cathode, A = Anode, G = Gate

Symbol	Test Conditions	Maximum Ratings		Features
I _{T(RMS)}	T _{VJ} = T _{VJM}	75	A	
I _{T(AV)M}	T _C = 75°C; 180° sine	48	A	
I _{TSM}	T _{VJ} = 45°C; V _R = 0 V	520	A	
	t = 10 ms (50 Hz), sine t = 8.3 ms (60 Hz), sine	560	A	
	T _{VJ} = T _{VJM} V _R = 0 V	460	A	
	t = 10 ms (50 Hz), sine t = 8.3 ms (60 Hz), sine	500	A	
i ² t	T _{VJ} = 45°C V _R = 0 V	1350	A ² s	
	t = 10 ms (50 Hz), sine t = 8.3 ms (60 Hz), sine	1300	A ² s	
	T _{VJ} = T _{VJM} V _R = 0 V	1050	A ² s	
	t = 10 ms (50 Hz), sine t = 8.3 ms (60 Hz), sine	1030	A ² s	
(di/dt) _{cr}	T _{VJ} = T _{VJM} f = 50Hz, t _p = 200 μs V _D = 2/3 V _{DRM} I _G = 0.3 A di _G /dt = 0.3 A/μs	repetitive, I _T = 40 A non repetitive, I _T = I _{T(AV)M}	150 500	A/μs A/μs
(dv/dt) _{cr}	T _{VJ} = T _{VJM} ; R _{GK} = ∞; method 1 (linear voltage rise)	V _{DR} = 2/3 V _{DRM}	1000	V/μs
P _{GM}	T _{VJ} = T _{VJM} I _T = I _{T(AV)M}	t _p = 30 μs t _p = 300 μs	10 5 0.5	W W W
P _{G(AV)}				
V _{RGM}			10	V
T _{VJ}			-40...+140	°C
T _{VJM}			140	°C
T _{stg}			-40...+125	°C
M _d *	Mounting torque M3		1.13 10	Nm lb.in.
V _{ISOL} **	50/60 Hz, RMS, t = 1 minute, leads-to-tab		2500	V~
Weight			6	g

* Version A only; ** Version AR only

Data according to IEC 60747
IXYS reserves the right to change limits, test conditions and dimensions

Symbol	Test Conditions	Characteristic Values		
I_R, I_D	$T_{VJ} = T_{VJM}$; $V_R = V_{RRM}$; $V_D = V_{DRM}$	≤	5	mA
V_T	$I_T = 80 \text{ A}$; $T_{VJ} = 25^\circ\text{C}$	≤	1.64	V
V_{TO}	For power-loss calculations only ($T_{VJ} = 125^\circ\text{C}$)	0.85	V	
r_T		11	mΩ	
V_{GT}	$V_D = 6 \text{ V}$; $T_{VJ} = 25^\circ\text{C}$ $T_{VJ} = -40^\circ\text{C}$	≤	1.5	V
I_{GT}	$V_D = 6 \text{ V}$; $T_{VJ} = 25^\circ\text{C}$ $T_{VJ} = -40^\circ\text{C}$	≤	100	mA
V_{GD}	$T_{VJ} = T_{VJM}$;	$V_D = 2/3 V_{DRM}$	≤	0.2 V
I_{GD}			≤	10 mA
I_L	$T_{VJ} = 25^\circ\text{C}$; $t_p = 10 \mu\text{s}$ $I_G = 0.3 \text{ A}$; $di_G/dt = 0.3 \text{ A}/\mu\text{s}$	≤	150	mA
I_H	$T_{VJ} = 25^\circ\text{C}$; $V_D = 6 \text{ V}$; $R_{GK} = \infty$	≤	100	mA
t_{gd}	$T_{VJ} = 25^\circ\text{C}$; $V_D = 1/2 V_{DRM}$ $I_G = 0.3 \text{ A}$; $di_G/dt = 0.3 \text{ A}/\mu\text{s}$	≤	2	μs
R_{thJC}	DC current	0.62	K/W	
R_{thJK}	DC current	0.82	K/W	
a	Max. acceleration, 50 Hz	50	m/s ²	

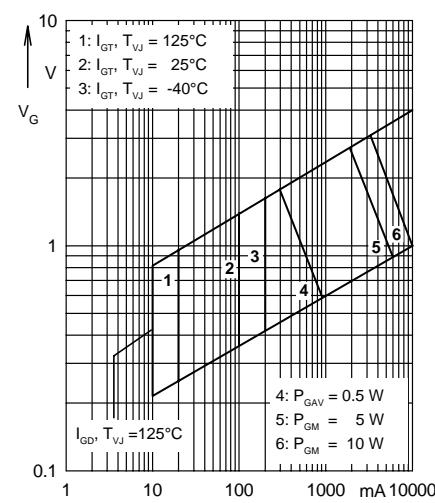
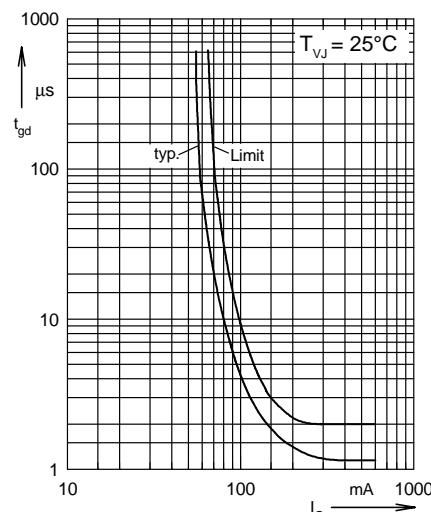
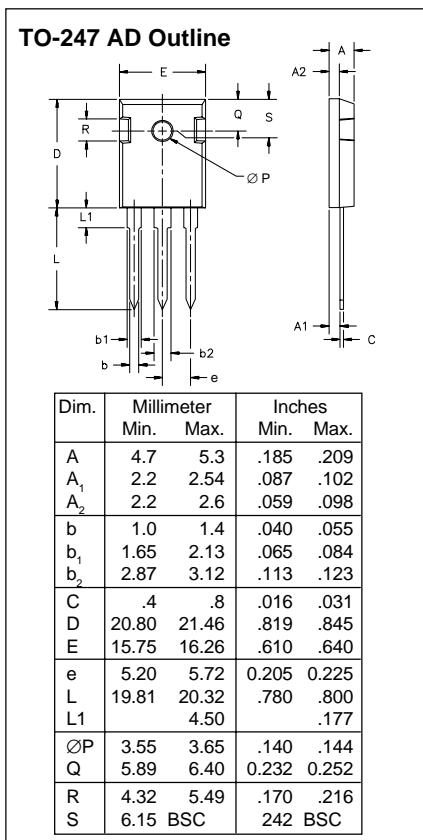


Fig. 1 Gate trigger range

Fig. 2 Gate controlled delay time t_{gd} 

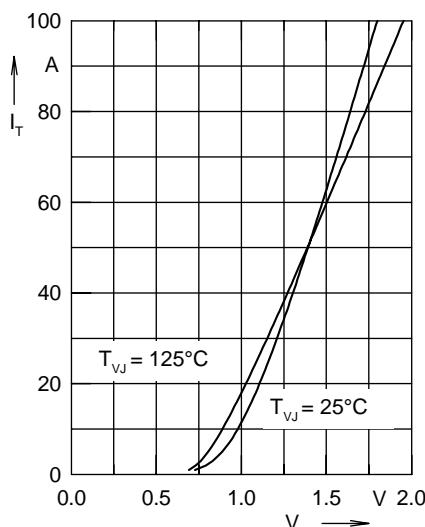


Fig. 3 Forward characteristics

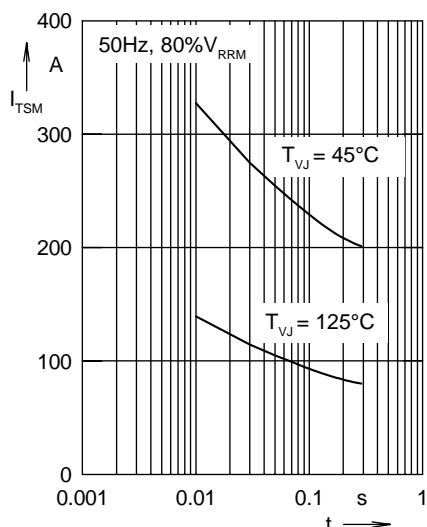
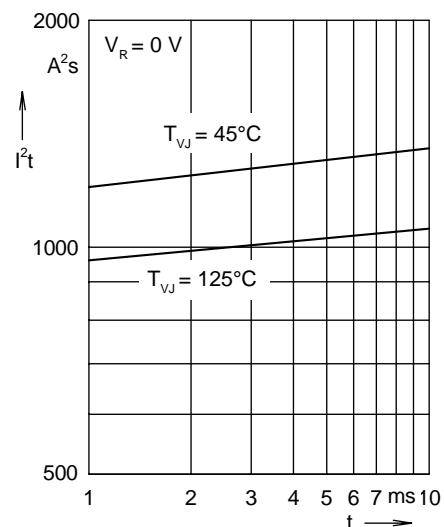
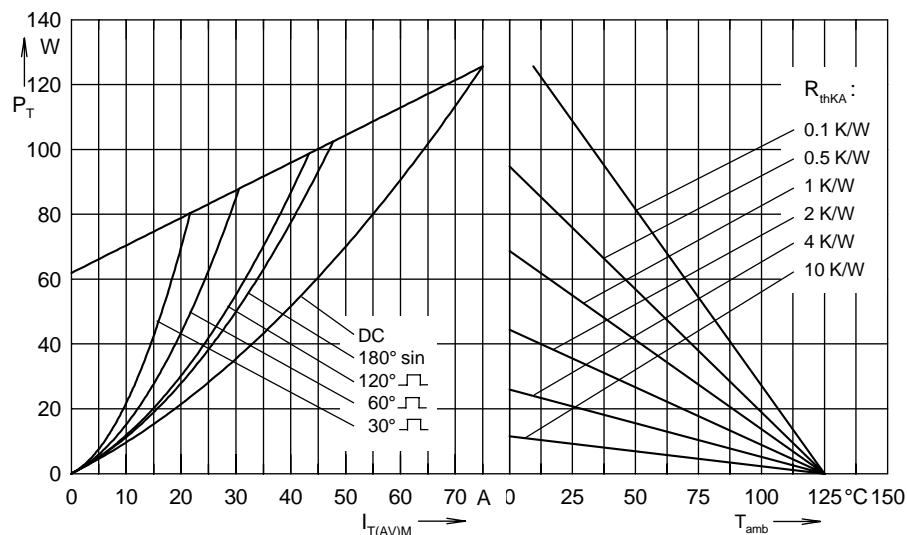
Fig. 4 Surge overload current
 I_{TSM} : crest value, t : durationFig. 5 I^2t versus time (1-10 ms)

Fig. 6 Power dissipation versus forward current and ambient temperature

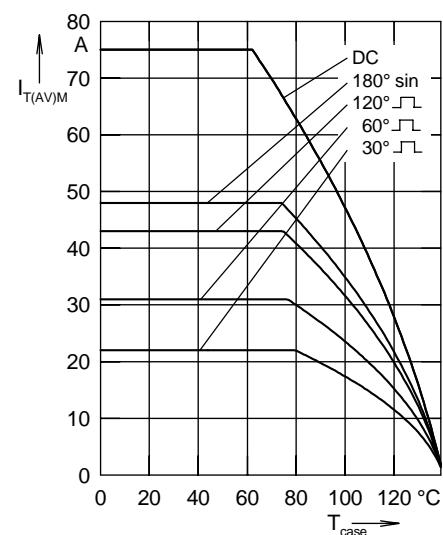


Fig. 7 Max. forward current at case temperature

 R_{thJC} for various conduction angles d :

d	R_{thJC} (K/W)
DC	0.62
180°	0.71
120°	0.748
60°	0.793
30°	0.817

Constants for Z_{thJC} calculation:

i	R_{thi} (K/W)	t_i (s)
1	0.206	0.013
2	0.362	0.118
3	0.052	1.488

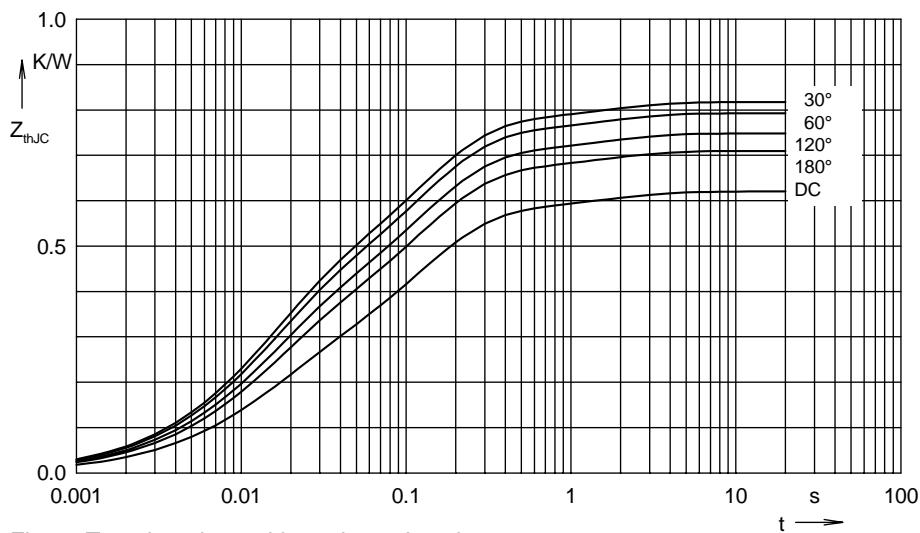


Fig. 8 Transient thermal impedance junction to case